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XA-9335  
PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of:

Yutaka SUENAGA et al.

Appln. No.: 09/615,081

Group Art Unit: 2872

Filed: July 12, 2000

Examiner: M. Robinson

For: Catadioptric Optical System and Exposure Apparatus  
Equipped with the Same

FOURTH SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT  
AND STATEMENT UNDER 37 C.F.R. § 1.97(e)

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Attn: Mail Stop AF

Sir:

Pursuant to 37 C.F.R. § 1.56, and without any  
assertion as to materiality or prior art effect, the  
document listed on the attached Form PTO-1449 is hereby  
cited.

The document on the attached List was cited in a  
counterpart European patent application.


A check for \$180.00 is attached to cover the fee set  
forth in 37 C.F.R. § 1.17(p).

The Commissioner is hereby authorized to charge to Deposit Account No. 50-1165 any fees under 37 C.F.R. §§ 1.16 and 1.17 that may be required by this paper and to credit any overpayment to that Account. If any extension of time is required in connection with the filing of this paper and has not been requested separately, such extension is hereby requested.

STATEMENT UNDER 37 C.F.R. § 1.97(e)

The undersigned hereby states that each item of information contained in this Supplemental Information Disclosure Statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this Statement.

Respectfully requested,

By:   
Nelson H. Shapiro  
Reg. No. 17,095

MWS:lmb

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May 21, 2004

FORM PTO-1449

Atty. Docket No.

Appln. No.

XA-9335

09/615,081

**LIST OF DOCUMENTS CITED BY APPLICANT**

Applicant

Yutaka Suenaga et al.

Filing Date

July 12, 2000

Group

2872

**U.S. PATENT DOCUMENTS**

Examiner Initial	Document Number	Date	Name	Class	Sub-class	Filing Date
	AA					
	AB					
	AC					
	AD					
	AE					
	AF					
	AG					
	AH					
	AI					

**FOREIGN PATENT DOCUMENTS**

Examiner Initial	Document Number	Date	Country	Class	Sub-class	Translation
	AJ 1 079 253	2/28/01	EPO			
	AK					
	AL					
	AM					
	AN					
	AO					

**OTHER** (including author, title, date, pertinent pages, etc.)

	AP	
	AQ	
	AR	

Examiner

Date Considered

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

